

PRODUCT TECHNICAL SPECIFICATION MANUAL

Twinscan NXE High-Volume Semiconductor Lithography & Plasma Etch Cluster

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SECURITY CLASSIFICATION: HIGHLY CONFIDENTIAL (CLASS III)

OWNERSHIP: ASML / LAM RESEARCH JOINT SPECIFICATION

RELEASE DATE: JANUARY 10, 2026

TARGET SITE: FAB 2 / FAB 3 BARE METAL PRODUCTION LINE

1. GENERAL FACILITY & UTILITY INTERFACE

This section outlines the baseline environmental and infrastructure constraints required for the integration of the Twinscan cluster into the fab facility grid.

1.1 Environmental Specifications

Parameter	Target Operating Value	Allowable Tolerance	Shutdown Limit
Ambient Temperature	22.00 °C	± 0.10 °C	< 21.50 °C / > 22.50 °C
Relative Humidity (RH)	45.0 %	± 3.0 %	< 35.0 % / > 55.0 %
Cleanroom Airborne Particle	ISO Class 1 (0.1 µm)	N/A	Exceeding ISO Class 2
Floor Vibration Peak-to-Peak	VC-G Standard	N/A	Structural Interlock Trip

1.2 Electrical Power Infrastructure

The main power supply transformer must deliver continuous 3-phase alternating current adhering strictly to the electrical load parameters detailed below.

- **Input Voltage Allocation:** 480 V AC ± 5% (Steady State)
- **Line Frequency Range:** 60 Hz ± 0.5 Hz
- **Maximum Total Continuous Load:** 125 kVA
- **Voltage Sag Immunity Limit:** SEMI F47 Compliant (100% retention for up to 20 ms)

2. POWER DISTRIBUTION SYSTEM & CIRCUIT DESIGN

Detailed schematics and load mapping for internal breaker networks and sub-module power rails.

2.1 Sub-Breaker Power Mapping

Breaker ID	Target Sub-Module Assembly	Rated Capacity	Trip Current Threshold
CB-MAIN-01	Main System Power Bus	200 A	240 A (Immediate Trip)
CB-LITHO-02	EUV Source Cabinet	80 A	95 A
CB-COOL-09	Lens Cooling Inverter Matrix	40 A	48 A
CB-VAC-04	Turbo Molecular Pump Assembly	30 A	36 A
CB-STAGE-05	Dual Wafer Stage Linear Motors	50 A	60 A

2.2 Main Transformer Thermal Characteristics

The internal dry-type isolation transformer includes embedded PT100 Resistance Temperature Detectors (RTD) to prevent winding degradation under heavy duty cycle shifts.

- **Nominal Core Temperature Rise:** 85.0 °C above ambient
- **Maximum Allowable Winding Temperature:** 145.0 °C
- **Thermal Warning Alarm Level:** 130.0 °C
- **Automatic Thermal Trip Interlock:** 140.0 °C

3. LITHOGRAPHY ENGINE DETAILED SPECIFICATION (EQP-PH-09)

Engineering parameters for the Sub-10nm high-volume production lithography cluster tool.

3.1 Equipment Profile

- **Equipment Identifier Code:** EQP-PH-09
- **Process Designation:** Lithography Pattern Projection (PHOTO)
- **Operational Node Compatibility:** Sub-10nm EUV Array Processing

3.2 Illumination Subsystem Rated Power Boundaries

The illumination optics engine requires strict current clumping parameters to ensure critical dimension uniformity across the exposure slit.

Parameter Component	Lower Standard Bound	Upper Standard Bound	Peak Limit (Max 5 min)
Main Exposure Chamber Power	12.00 kW	13.00 kW	18.00 kW
Source Collector Drive Unit	24.50 kW	26.00 kW	30.00 kW
CO2 Laser Amplifier Stage	35.00 kW	38.50 kW	42.00 kW

3.3 Fluid Supply Interconnects

- **Cooling Liquid Material:** Ultra-Pure Water (UPW) with 5% Inhibited Ethylene Glycol
- **Inlet Fluid Supply Pressure Range:** 4.50 bar to 5.50 bar
- **Minimum Volumetric Flow Rate:** 18.5 L/min
- **Maximum Inlet Pressure Rating:** 6.50 bar

4. LENS THERMAL MANAGEMENT SUB-ASSEMBLY

Mechanical specifications for the sub-module assembly dedicated to lens refractive index stabilization.

4.1 Thermal Stabilization Parameters

Thermal anomalies in the lens elements dynamically shift the focal plane, leading directly to patterning line-width errors.

Measurement Point	Setpoint Target	Operational Guardband	Critical Limit
Lens Element Core Temp	22.000 °C	± 0.005 °C	± 0.010 °C
Chiller Loop Supply Temp	18.250 °C	± 0.020 °C	± 0.050 °C
Heat Exchanger Face Temp	20.400 °C	± 0.015 °C	± 0.040 °C

4.2 Mechanical Pump & Inverter Specifications

- **Cooling Pump Motor Type:** Brushless AC Synchronous Inverter Pump
- **Rated Power Consumption:** 4.80 kW (Nominal)
- **Maximum Operating Current:** 10.5 A
- **Inverter Drive Frequency Baseline:** 50.0 Hz to 62.0 Hz

5. LENS THERMAL REGULATION MECHANICAL FAULT CODES

Mechanical telemetry mapping for the Lens Cooling Module (LCM) assembly.

5.1 Diagnostic Fault Code Mapping

Fault ID	Telemetry Manifestation	Root Mechanical Cause	Mandatory Hardware Action
LCM-ERR-42A	Main Chamber Power > 15.00 kW continuously; Core Temp Deviation > 22.005 °C	Particulate accumulation inside fluid filter element causing severe flow resistance.	Isolate fluid line. Replace Main Filter element (Part No: ASML-FLT-99).
LCM-ERR-42B	Pump Inverter Current > 12.0 A; Flow Rate < 12.0 L/min	Impeller cavitation or internal mechanical bearing seizure.	Rebuild pump assembly. Replace bearing ring assembly (Part No: ASML-BRG-04).
LCM-ERR-43C	Inlet Pressure > 6.00 bar; Core Temp Stable	Proportional flow control valve stuck in closed position.	Cycle actuator power. If error persists, replace pneumatic control valve.

5.2 Filter Element Differential Pressure Limits

- **Clean Filter Differential Pressure (ΔP):** 0.25 bar
- **Filter Warning Active Limit (ΔP):** 0.85 bar
- **Filter Clogged Interlock Level (ΔP):** 1.20 bar (Triggers hardware execution halt)

6. ETCH CLUSTER COMPONENT SPECIFICATION (EQP-ET-03)

Engineering parameters for the high-density plasma dry etching system.

6.1 Equipment Profile

- **Equipment Identifier Code:** EQP-ET-03
- **Process Designation:** High-Density Plasma Reactive Ion Etching (ETCH)
- **Operational Technology:** Inductively Coupled Plasma (ICP) Source Ring

6.2 RF Generator Component Ratings

The RF power generation framework utilizes a dual-source matching network to maintain plasma discharge stability under shifting gas ratios.

Sub-Assembly Component	Target Base Value	Tolerable Deviation	Absolute Hardware Limit
Source RF Generator Power	3.50 kW	± 0.15 kW	4.00 kW (Trip)
Bias RF Generator Power	1.20 kW	± 0.08 kW	1.50 kW
Total System Main Line Power	22.00 kW	24.50 kW	30.00 kW

6.3 Gas Delivery Mass Flow Controller (MFC) Standard Ratings

- **Process Gas Line 1 (SF6):** 500 sccm Full Scale [± 0.5% Accuracy]
- **Process Gas Line 2 (CH2F2):** 200 sccm Full Scale [± 0.5% Accuracy]
- **Process Gas Line 3 (Ar):** 1000 sccm Full Scale [± 0.5% Accuracy]

7. VACUUM CHAMBER & SUBSTRATE HOLDER (ESC) SPECIFICATIONS

Mechanical parameters governing the process pressure control loop and wafer clamping mechanism.

7.1 Vacuum Level Baseline

Operating Phase	Target Chamber Pressure	Throttle Valve State	Gas Load Capacity
Base Base Vacuum Pumpdown	5.0×10^{-7} Torr	Fully Open (100%)	0 sccm
Process Plasma Execution	10.0 to 50.0 mTorr	Dynamic Dynamic Modulation	250 to 850 sccm
Wafer Exchange Purge Step	120.0 mTorr	Position Fixed (15%)	1200 sccm (N2)

7.2 Electrostatic Chuck (ESC) Clamping System

- DC Clamping Voltage Baseline: 1200 V DC \pm 20 V
- Helium (He) Back Pressure Setpoint: 15.0 Torr
- Helium Leak Flow Warning Boundary: > 2.5 sccm
- ESC Upper Electrothermal Limit: 110.0 °C

8. PLASMA MATCHING NETWORK MECHANICAL FAULT CODES

Diagnostic criteria for RF matching assemblies on the EQP-ET-03 dry etch platform.

8.1 Impedance Matcher Error Mapping

Fault ID	Telemetry Manifestation	Root Mechanical Cause	Mandatory Hardware Action
MAT-ERR-88B	Total Power hunts between 15.00 kW and 28.00 kW; Chamber Pressure > 50.0 mTorr	Servo motor gear wear or vacuum capacitor insulation breakdown in the Matcher.	Halt RF power. Rebuild Matcher assembly. Replace Capacitor stack (Part No: LAM-CAP-03).
MAT-ERR-89A	Reflected Power > 350 W; Phase Angle Shift > 45°	RF transmission strap fracture or structural grounding strap failure.	Inspect Chamber grounding mesh. Replace silver-plated copper strap (Part No: LAM-STP-12).
MAT-ERR-90F	ESC Temp Gradient Deviation > 8.5 °C	Helium gas delivery micro-channel clogging across the cooling face plate.	Perform chamber wet clean. Back-flush substrate lines with isopropyl alcohol.

8.2 RF Generator Reflected Power Thresholds

- **Optimal Matching Reflected Power:** < 15 W
- **Operational Alert Level:** > 150 W
- **RF Generator Trip Protection Boundary:** > 400 W (Shuts down plasma within 5 ms)

9. CORE CONSUMABLE PARTS & MECHANICAL COMPONENT REGISTRY

Official manufacturer part numbers and physical dimensions for lifecycle tracking and replacement intervals.

9.1 Replacement Component Matrix

Component Name	OEM Part Number	Critical Dimensions	Expected Lifecycle
LCM High-Flow Fluid Filter	ASML-FLT-99	145 mm L x 65 mm D	3,500 Arc Hours
Inverter Pump High-Load Bearing	ASML-BRG-04	ID 25 mm / OD 52 mm	12,000 Operating Hours
Vaccum Capacitor Stack (Matcher)	LAM-CAP-03	12-1200 pF / 15 kV	5,000 Plasma On Hours
RF Silver Grounding Strap	LAM-STP-12	220 mm x 25 mm x 0.5 mm	2,000 RF Cycles
Quartz Focus Ring Element	LAM-RNG-88	300 mm Inner D Standard	450 RF Hours (Consumable)

9.2 Verification Testing Criteria

Following any mechanical component swap documented above, the equipment must complete a full 12-point initialization matrix. Sensor logs must verify that `Power_Usage_kW` and `Temperature_C` return to the baseline values defined in Chapter 3.2 and Chapter 6.2 before dummy wafer processing is authorized.